Notice of References Cited Application/Control No. 10/599,431 Examiner THIEN TRAN Applicant(s)/Patent Under Reexamination SUENAGA ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,274,208 A	12-1993	Noda, Tomimitsu	219/715
*	В	US-6,362,463 B1	03-2002	Bessyo et al.	219/715
*	С	US-2005/0174819 A1	08-2005	Yang, Hui Chiang	363/127
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	ı	US-			
	J	US-			
	K	US-			
	┙	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Ν	JP 2003-259643	09-2003	Japan	Manabu	H02M 3/28
	0	JP 2003-257604	09-2003	Japan	Teruya	H05B 6/12
	Ρ					
	Ø					
	R					
	Ø					
·	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	W	
	×	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.